

### 30A, 60V, ESD Rated, 0.047 Ohm, Logic Level N-Channel Power MOSFETs

These are N-Channel power MOSFETs manufactured using the MegaFET process. This process, which uses feature sizes approaching those of LSI integrated circuits gives optimum utilization of silicon, resulting in outstanding performance. They were designed for use in applications such as switching regulators, switching converters, motor drivers and relay drivers. These transistors can be operated directly from integrated circuits.

These transistors incorporate ESD protection and are designed to withstand 2kV (Human Body Model) of ESD.

Formerly developmental type TA49027.

### Ordering Information

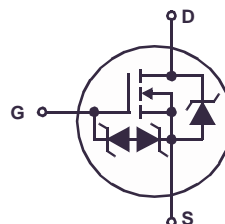
PART NUMBER	PACKAGE	BRAND
RFP30N06LE	TO-220AB	P30N06LE
RF1S30N06LESM	TO-263AB	1S30N06L

NOTE: When ordering use the entire part number. Add suffix, 9A, to obtain the TO-263 variant in tape and reel i.e. RF1S30N06LESM9A.

### Features

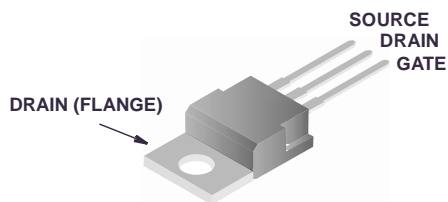
- 30A, 60V
- $r_{DS(ON)} = 0.047\Omega$
- 2kV ESD Protected
- Temperature Compensating PSpice® Model
- Peak Current vs Pulse Width Curve
- UIS Rating Curve
- Related Literature
  - TB334 "Guidelines for Soldering Surface Mount Components to PC Boards"

### Symbol

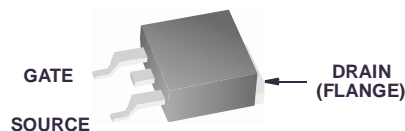


### Packaging

**JEDEC TO-220AB**



**JEDEC TO-263AB**



# RFP30N06LE, RF1S30N06LESM

## Absolute Maximum Ratings $T_A = 25^{\circ}\text{C}$ , Unless Otherwise Specified

	RFP30N06LE, RF1S30N06LESM	UNITS
Drain to Source Voltage (Note 1) . . . . .	$V_{DS}$ 60	V
Drain to Gate Voltage ( $R_{GS} = 20\text{k}\Omega$ ) (Note 1) . . . . .	$V_{DGR}$ 60	V
Gate to Source Voltage . . . . .	$V_{GS}$ +10, -8	V
Continuous Drain Current . . . . .	$I_D$ 30	A
Pulsed Drain Current (Note 3) . . . . .	$I_{DM}$ Refer to Peak Current Curve	
Pulsed Avalanche Rating . . . . .	$E_{AS}$ Refer to UIS Curve	
Power Dissipation . . . . .	$P_D$ 96	W
Derate Above $25^{\circ}\text{C}$ . . . . .	0.645	W/ $^{\circ}\text{C}$
Electrostatic Discharge Rating, MIL-STD-883, Category B(2) . . . . .	ESD 2	kV
Operating and Storage Temperature . . . . .	$T_J, T_{STG}$ -55 to 175	$^{\circ}\text{C}$
Maximum Temperature for Soldering		
Leads at 0.063in (1.6mm) from Case for 10s . . . . .	$T_L$ 300	$^{\circ}\text{C}$
Package Body for 10s, See Techbrief 334 . . . . .	$T_{pk}$ 260	$^{\circ}\text{C}$

CAUTION: Stresses above those listed in "Absolute Maximum Ratings" may cause permanent damage to the device. This is a stress only rating and operation of the device at these or any other conditions above those indicated in the operational sections of this specification is not implied.

### NOTE:

1.  $T_J = 25^{\circ}\text{C}$  to  $150^{\circ}\text{C}$ .

## Electrical Specifications $T_C = 25^{\circ}\text{C}$ , Unless Otherwise Specified

PARAMETER	SYMBOL	TEST CONDITIONS		MIN	TYP	MAX	UNITS
Drain to Source Breakdown Voltage	BV <sub>DSS</sub>	I <sub>D</sub> = 250μA, V <sub>GS</sub> = 0V, Figure 11		60	-	-	V
Gate to Threshold Voltage	V <sub>GS(TH)</sub>	V <sub>GS</sub> = V <sub>DS</sub> , I <sub>D</sub> = 250μA, Figure 10		1	-	2	V
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>DS</sub> = Rated B <sub>V</sub> DSS, V <sub>GS</sub> = 0		-	-	25	μA
		V <sub>DS</sub> = 0.8 x Rated B <sub>V</sub> DSS, V <sub>GS</sub> = 0, T <sub>C</sub> = 150°C		-	-	250	μA
Gate to Source Leakage Current	I <sub>GSS</sub>	V <sub>GS</sub> = +10, -8V		-	-	±10	μA
Drain to Source On Resistance (Note 2)	r <sub>DS(ON)</sub>	I <sub>D</sub> = 30A, V <sub>GS</sub> = 5V, Figure 9		-	-	0.047	Ω
Turn-On Time	t <sub>ON</sub>	V <sub>DD</sub> = 30V, I <sub>D</sub> = 30A, R <sub>L</sub> = 1Ω, V <sub>GS</sub> = 5V, R <sub>GS</sub> = 2.5Ω, Figures 13, 16, 17		-	-	140	ns
Turn-On Delay Time	t <sub>d(ON)</sub>			-	11	-	ns
Rise Time	t <sub>r</sub>			-	88	-	ns
Turn-Off Delay Time	t <sub>d(OFF)</sub>			-	30	-	ns
Fall Time	t <sub>f</sub>			-	40	-	ns
Turn-Off Time	t <sub>OFF</sub>			-	-	100	ns
Total Gate Charge	Q <sub>g(TOT)</sub>	V <sub>GS</sub> = 0V to 10V	V <sub>DD</sub> = 48V, I <sub>D</sub> = 30A, R <sub>L</sub> = 1.6Ω, Figures 18, 19	-	51	62	nC
Gate Charge at 5V	Q <sub>g(5)</sub>	V <sub>GS</sub> = 0V to 5V		-	28	34	nC
Threshold Gate Charge	Q <sub>g(TH)</sub>	V <sub>GS</sub> = 0V to 1V		-	1.8	2.6	nC
Input Capacitance	C <sub>ISS</sub>	V <sub>DS</sub> = 25V, V <sub>GS</sub> = 0V, f = 1MHz, Figure 12		-	1350	-	pF
Output Capacitance	C <sub>OSS</sub>			-	290	-	pF
Reverse Transfer Capacitance	C <sub>RSS</sub>			-	85	-	pF
Thermal Resistance Junction to Case	R <sub>θJC</sub>			-	-	1.55	°C/W
Thermal Resistance Junction to Ambient	R <sub>θJA</sub>			-	-	80	°C/W

## Source to Drain Diode Specifications

PARAMETER	SYMBOL	TEST CONDITIONS	MIN	TYP	MAX	UNITS
Source to Drain Diode Voltage (Note 2)	$V_{SD}$	$I_{SD} = 30\text{A}$	-	-	1.5	V
Diode Reverse Recovery Time	$t_{rr}$	$I_{SD} = 30\text{A}$ , $dI_{SD}/dt = 100\text{A}/\mu\text{s}$	-	-	125	ns

### NOTES:

2. Pulse Test: Pulse Width  $\leq 300\text{ms}$ , Duty Cycle  $\leq 2\%$ .
3. Repetitive Rating: Pulse Width limited by max junction temperature. See Transient Thermal Impedance Curve (Figure 3) and Peak Current Capability Curve (Figure 5).

# Typical Performance Curves Unless Otherwise Specified

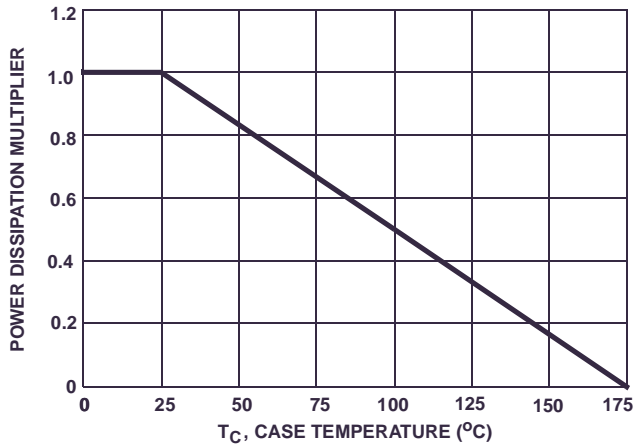


FIGURE 1. NORMALIZED POWER DISSIPATION vs CASE TEMPERATURE

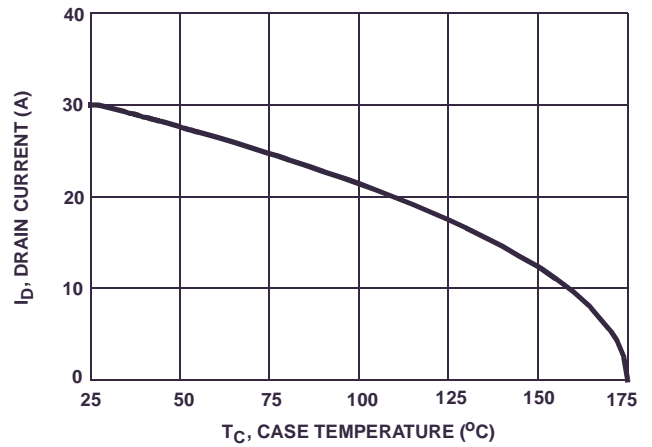


FIGURE 2. MAXIMUM CONTINUOUS DRAIN CURRENT vs CASE TEMPERATURE

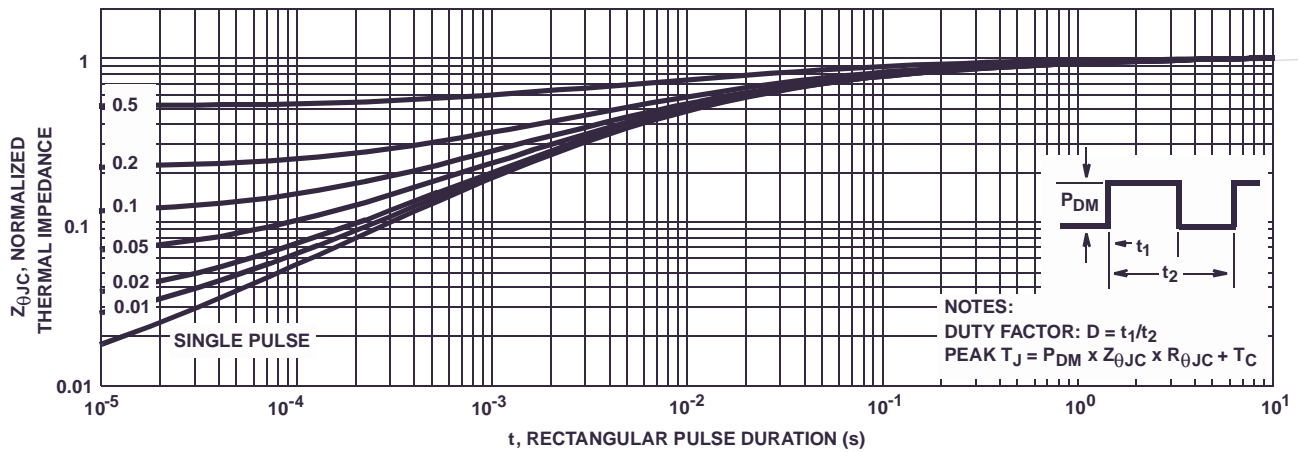


FIGURE 3. NORMALIZED MAXIMUM TRANSIENT THERMAL IMPEDANCE

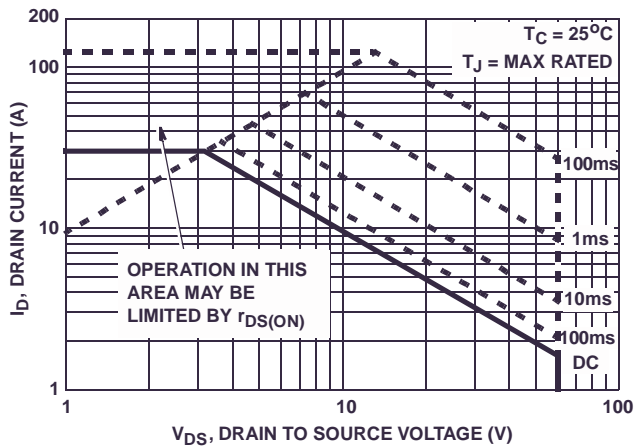


FIGURE 4. FORWARD BIAS SAFE OPERATING AREA

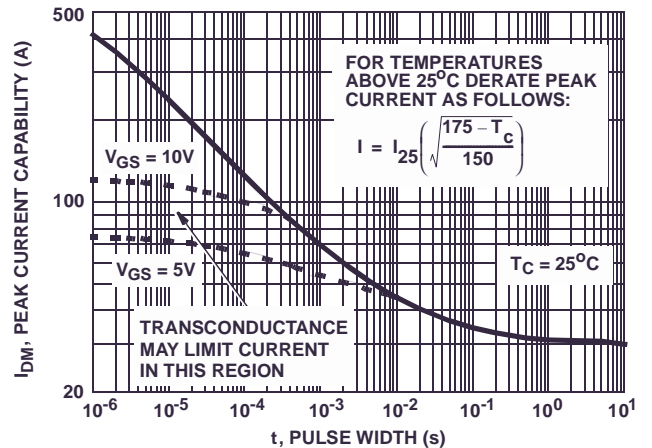
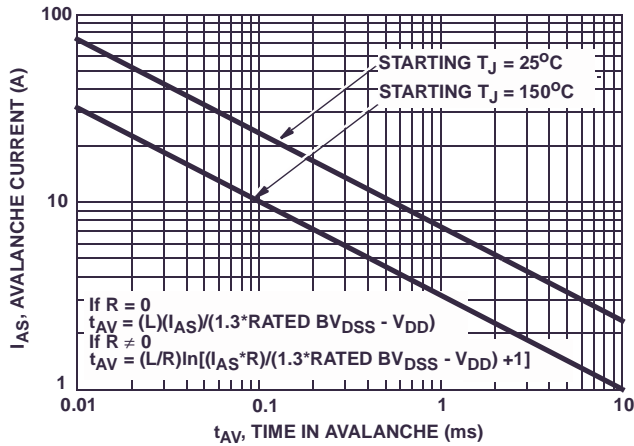


FIGURE 5. PEAK CURRENT CAPABILITY

# Typical Performance Curves Unless Otherwise Specified (Continued)



NOTE: Refer to Fairchild Application Notes AN9321 and AN9322.

FIGURE 6. UNCLAMPED INDUCTIVE SWITCHING

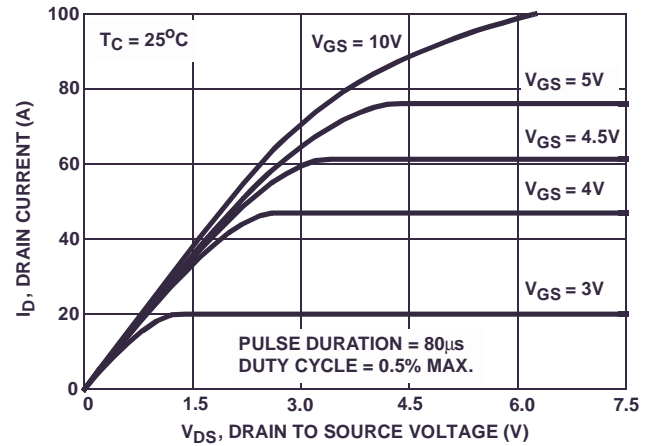


FIGURE 7. SATURATION CHARACTERISTICS

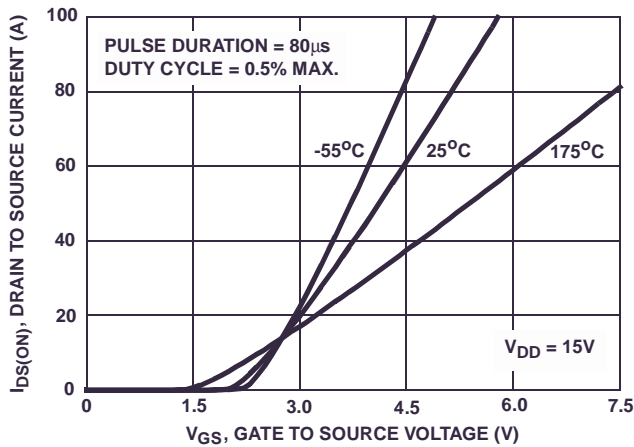


FIGURE 8. TRANSFER CHARACTERISTICS

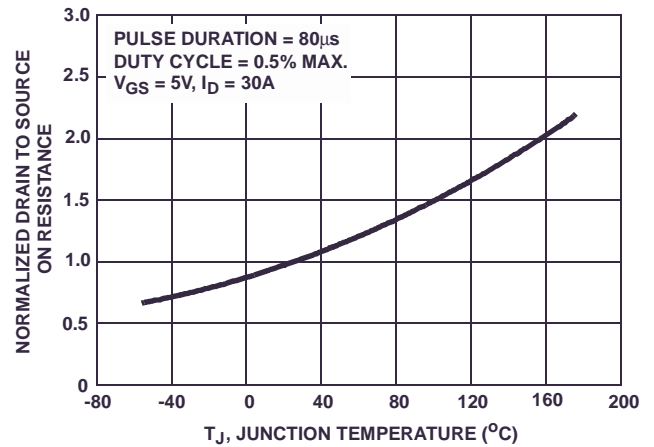


FIGURE 9. NORMALIZED DRAIN TO SOURCE ON RESISTANCE vs JUNCTION TEMPERATURE

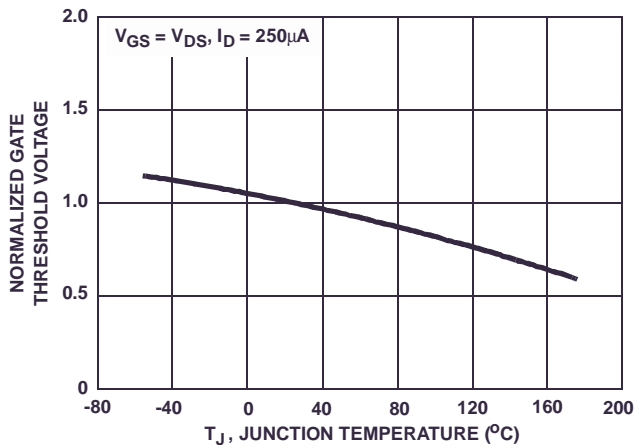


FIGURE 10. NORMALIZED GATE THRESHOLD VOLTAGE vs JUNCTION TEMPERATURE

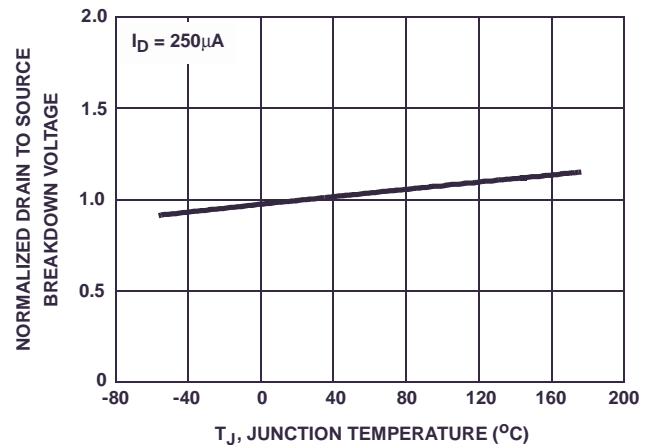


FIGURE 11. NORMALIZED DRAIN TO SOURCE BREAKDOWN VOLTAGE vs JUNCTION TEMPERATURE

## Typical Performance Curves Unless Otherwise Specified (Continued)

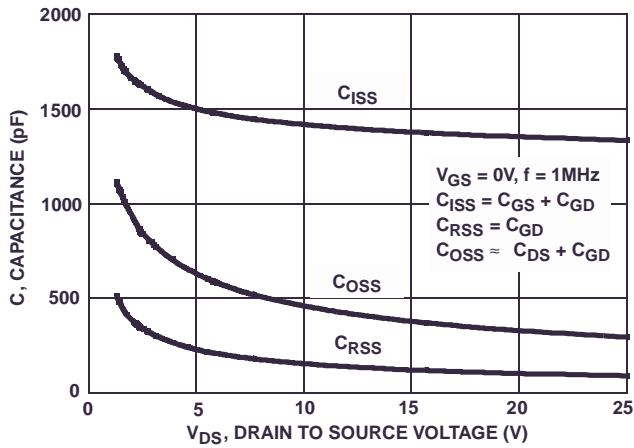
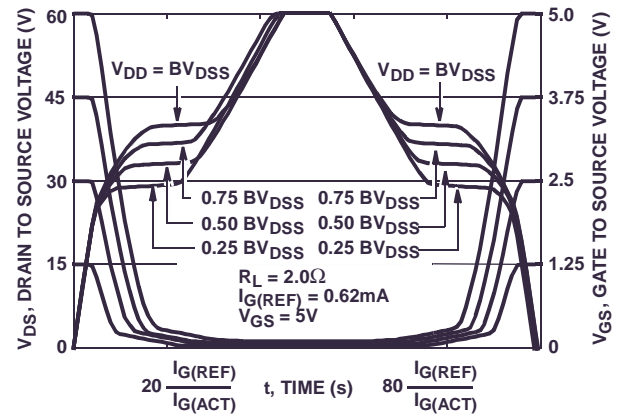


FIGURE 12. CAPACITANCE vs DRAIN TO SOURCE VOLTAGE



NOTE: Refer to Fairchild Application Notes AN7254 and AN7260.

FIGURE 13. NORMALIZED SWITCHING WAVEFORMS FOR CONSTANT GATE CURRENT

## Test Circuits and Waveforms

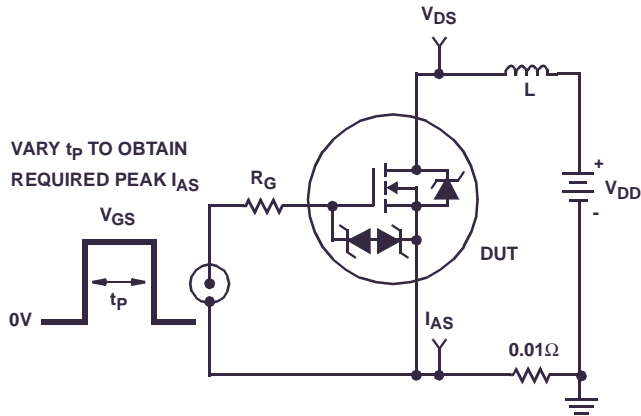


FIGURE 14. UNCLAMPED ENERGY TEST CIRCUIT

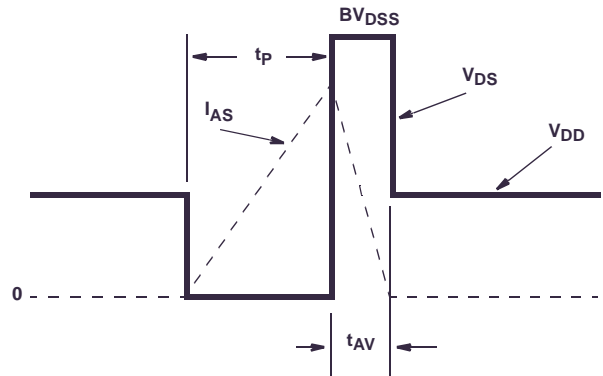


FIGURE 15. UNCLAMPED ENERGY WAVEFORMS

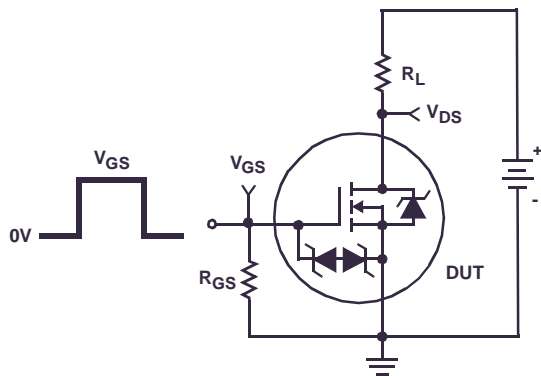


FIGURE 16. SWITCHING TIME TEST CIRCUIT

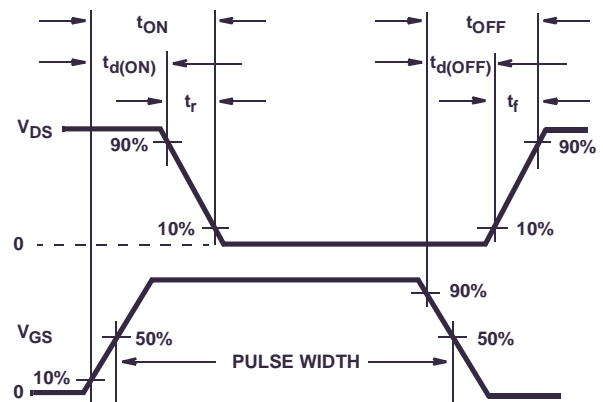


FIGURE 17. RESISTIVE SWITCHING WAVEFORMS

**Test Circuits and Waveforms** (Continued)

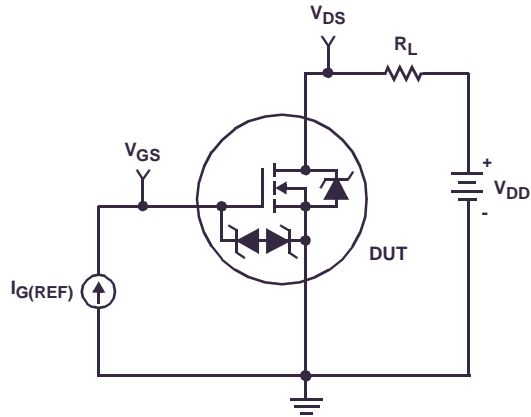


FIGURE 18. GATE CHARGE TEST CIRCUIT

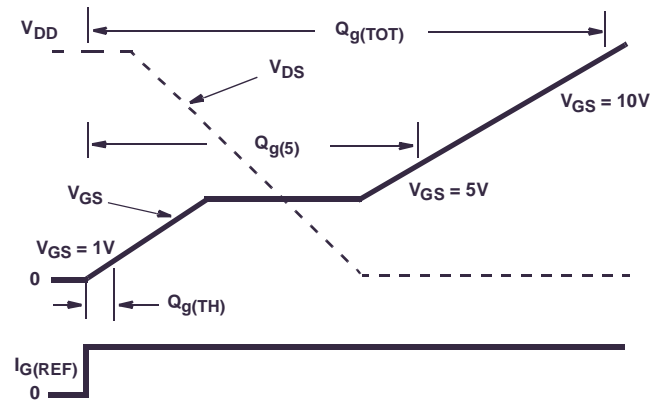


FIGURE 19. GATE CHARGE WAVEFORMS

**PSpICE Electrical Model**

SUBCKT RFP30N06LE 2 1 3; rev 6/2/93  
 CA 12 8 1 3.34e-9  
 CB 15 14 3.44e-9  
 CIN 6 8 0 1.343e-9

DBODY 7 5 DBDMOD  
 DBREAK 5 11 DBKMOD  
 DESD1 91 9 DESD1MOD  
 DESD2 91 7 DESD2MOD  
 DPLCAP 10 5 DPLCAPMOD

EBREAK 11 7 17 18 75.39  
 EDS 14 8 5 8 1  
 EGS 13 8 6 8 1  
 ESG 6 10 6 8 1  
 EVTO 20 6 18 8 1

IT 8 17 1

LDRAIN 2 5 1e-9  
 LGATE 1 9 7.22e-9  
 LSOURCE 3 7 6.31e-9

MOS1 16 6 8 8 MOSMOD M = 0.99  
 MOS2 16 21 8 8 MOSMOD M = 0.01

RBREAK 17 18 RBKMOD 1  
 RDRAIN 50 16 RDSMOD 11.86e-3  
 RGATE 9 20 2.52  
 RIN 6 8 1e9  
 RSCL1 5 51 RSLVCMOD 1e-6  
 RSCL2 5 50 1e3  
 RSOURCE 8 7 RDSMOD 26.6e-3  
 RVTO 18 19 RVTOMOD 1

S1A 6 12 13 8 S1AMOD  
 S1B 13 12 13 8 S1BMOD  
 S2A 6 15 14 13 S2AMOD  
 S2B 13 15 14 13 S2BMOD

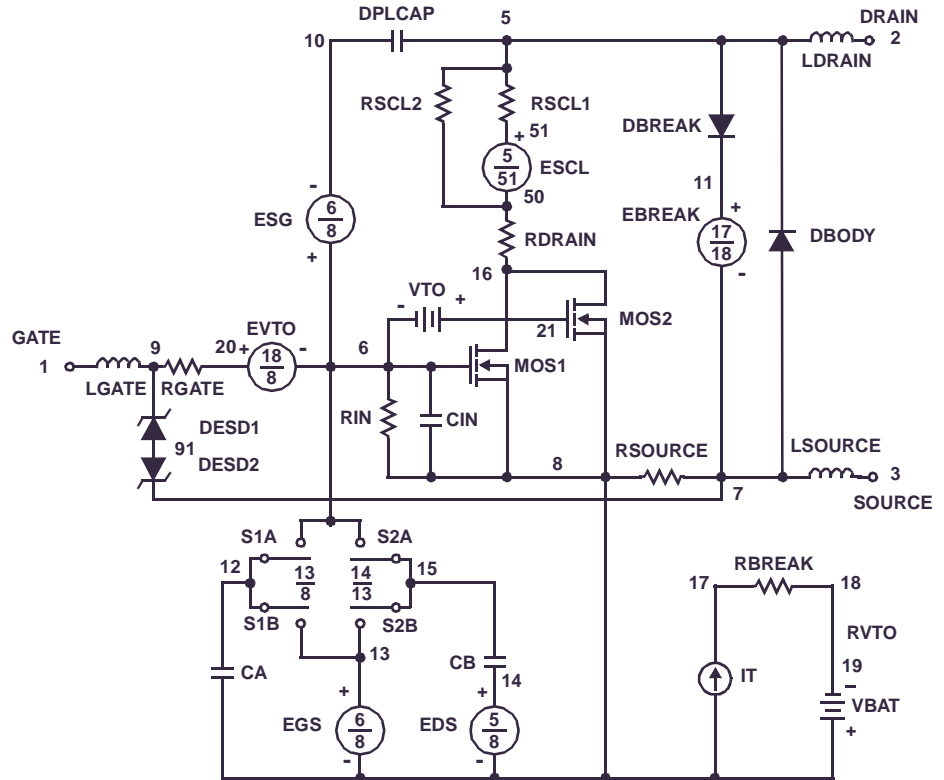
VBAT 8 19 DC 1  
 VTO 21 6 0.5

ESCL 51 50 VALUE = {(V(5,51)/ABS(V(5,51)))\*(PWR(V(5,51)\*1e6/89,7))}

.MODEL DBDMOD D (IS = 3.80e-13 RS = 1.12e-2 TRS1 = 1.61e-3 TRS2 = 6.08e-6 CJO = 1.05e-9 TT = 3.84e-8)  
 .MODEL DBKMOD D (RS = 1.82e-1 TRS1 = 7.50e-3 TRS2 = -4.0e-5)  
 .MODEL DESD1MOD D (BV = 13.54 TBV1 = 0 TBV2 = 0 RS = 45.5 TRS1 = 0 TRS2 = 0)  
 .MODEL DESD2MOD D (BV = 11.46 TBV1 = -7.576e-4 TBV2 = -3.0e-6 RS = 0 TRS1 = 0 TRS2 = 0)  
 .MODEL DPLCAPMOD D (CJO = 0.591e-9 IS = 1e-30 N = 10)  
 .MODEL MOSMOD NMOS (VTO = 1.94 KP = 139.2 IS = 1e-30 N = 10 TOX = 1 L = 1u W = 1u)  
 .MODEL RBKMOD RES (TC1 = 1.07e-3 TC2 = -3.03e-7)  
 .MODEL RDSMOD RES (TC1 = 5.38e-3 TC2 = 1.64e-5)  
 .MODEL RSLVCMOD RES (TC1 = 1.75e-3 TC2 = 3.90e-6)  
 .MODEL RVTOMOD RES (TC1 = -2.15e-3 TC2 = -5.43e-6)  
 .MODEL S1AMOD VSWITCH (RON = 1e-5 ROFF = 0.1 VON = -4.05 VOFF = -1.5)  
 .MODEL S1BMOD VSWITCH (RON = 1e-5 ROFF = 0.1 VON = -1.5 VOFF = -4.05)  
 .MODEL S2AMOD VSWITCH (RON = 1e-5 ROFF = 0.1 VON = -2.2 VOFF = 2.8)  
 .MODEL S2BMOD VSWITCH (RON = 1e-5 ROFF = 0.1 VON = 2.8 VOFF = -2.2)

.ENDS

NOTE: For further discussion of the PSpICE model, consult **A New PSpICE Sub-Circuit for the Power MOSFET Featuring Global Temperature Options**; IEEE Power Electronics Specialist Conference Records 1991.



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CoolFET™	FRFET™	MicroPak™	QS™	SyncFET™
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DOMET™	GTO™	MSX™	Quiet Series™	TINYOPTO™
EcoSPARK™	HiSeC™	MSXPro™	RapidConfigure™	TruTranslation™
E <sup>2</sup> CMOS™	I <sup>2</sup> C™	OCX™	RapidConnect™	UHC™
EnSigna™	ImpliedDisconnect™	OCXPro™	SILENT SWITCHER®	UltraFET®
FACT™	ISOPLANAR™	OPTOLOGIC®	SMART START™	VCX™
Across the board. Around the world.™	OPTOPLANAR™	SPM™		
The Power Franchise™	PACMAN™	Stealth™		
Programmable Active Droop™	POP™	SuperFET™		

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2. A critical component is any component of a life support device or system whose failure to perform can be reasonably expected to cause the failure of the life support device or system, or to affect its safety or effectiveness.

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Datasheet Identification	Product Status	Definition
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